

FA / CHARACTERIZATION / VERIFICATION

Robust and stable prober ideal for diverse applications such as small geometry probing, applications using high power optics, design debug, wafer level reliability (WLR) and electro static discharge (ESD)



DESIGNED FOR ANALYTICAL PROBING

The PML 8000 analytical prober for up to 8-inch wafers delivers a cost effective prober for failure analysis, device characterization and inline process verification. Its compact base design and extensive feature set are ideally suited for diverse applications, including: small geometry probing; applications using high power optics; design debug; wafer level reliability (WLR) and electro static discharge (ESD).

CONFIGURABLE FOR MANY APPLICATIONS

PML 8000 can be configured with ShieldMaster™, a guarded environmental chamber, to accommodate low-level and low temperature leakage requirements.

With controls located at the front of the system, the PML 8000 offers fine and coarse positioning of the 8-inch by 8-inch XY stage. The Z control of the platen is also situated at the front of the system, offering 2 inches of Z movement as well as 0.015 inch fine control for probing.

Setup, positioning and adjustment of manipulators on the PML 8000 are easy and its robust, stable probing platform accommodates a wide range of accessories, including: manipulators; standard and custom chuck plates; manual, motorized or programmable microscope mounts; and microscopes from leading optics manufacturers, and more.

Should packaged device testing be required, the PML 8000 includes a standard vice-chuck. This unit has adjustable clamps that range from 1-inch to 6-inches and offers 0.5-inches of clearance between the PCB and lead screw for optimal safety.

PML 8000 offers cost effective probing of wafers or packaged devices for semiconductor, research and education.

PML 8000 FEATURES TO MAXIMIZE PERFORMANCE

- Small footprint
- Easily configured for different applications
- Robust, highly stable probing platform
- Vice chuck
- Large platen area



SPECIFICATIONS

XY STAGE

| X Travel | 210 mm (8.25") manual travel |
|----------|------------------------------|
| Y Travel | 235 mm (9.25") manual travel |
| Pitch | 25 mm (1") lead screws |

LINEAR MOTION GUIDES

Concentric fine/coarse controls for stage operation 1:1 ratio for fast positioning (25 mm/1" rev). Control wheels at front of machine, isolated from lead screws.

Сниск

| 205 mm (8") electroless nickel-plated aluminum | | |
|--|--|--|
| Flat to within 8 µm (0.0003") | | |
| Micrometer drive theta, 15° | | |
| Fixed height | | |
| Packaged device holder | | |

PLATEN

| 10 mm (0.4") thick open front electroless nickel-plated steel | | | | |
|---|--|--|--|--|
| top supported by 4 steel pillars | | | | |
| 50 mm (2") manual height adjustment - 4 corners driven | | | | |
| Height adjustment via either of the two front wheels | | | | |
| Horizontally operated lever for fine vertical lift | | | | |
| Suitable for magnetic or vacuum base manipulators | | | | |
| Separation lift (option) 10 mm (0.4") | | | | |
| Probing lift 0.3 mm (0.012") | | | | |

PHYSICAL DIMENSIONS

| Width | 620 mm (24.25") |
|--------|-----------------|
| Depth | 680 mm (27") |
| Height | 610 mm (24") |
| Weight | 84 kg (185 lb) |

SERVICES

| <u>Vacuum</u> | 0.5 cfm @ 20" Hg | |
|---------------|------------------|--|
| | | |

Options and Accessories

| Manual, motorized or programmable microscope mount | | | |
|--|--|--|--|
| Lasers for semiconductor failure analysis | | | |
| Package device holder | | | |
| Vacuum manifold | | | |
| Probe card holder | | | |
| Chuck plates | | | |
| ShieldMaster™ environmental chamber | | | |

PROGRAMMABLE MICROSCOPE MOUNT (PMM)

| XY Resolution | 1 μm |
|------------------|--------------|
| XY Accuracy | ± 7 μm |
| XY Repeatability | ≤ 2 µm |
| XY Travel | 100 mm |
| XY Speed | Up to 6 mm/s |
| Z Resolution | 1µm |
| Z Speed | Up to 3 mm/s |
| Z Repeatability | ≤ 2 µm |
| Z Lift Travel | 100 mm |
| Z Lift Method | Motor |
| - | |



Programmable Microscope Mount (PMM)



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